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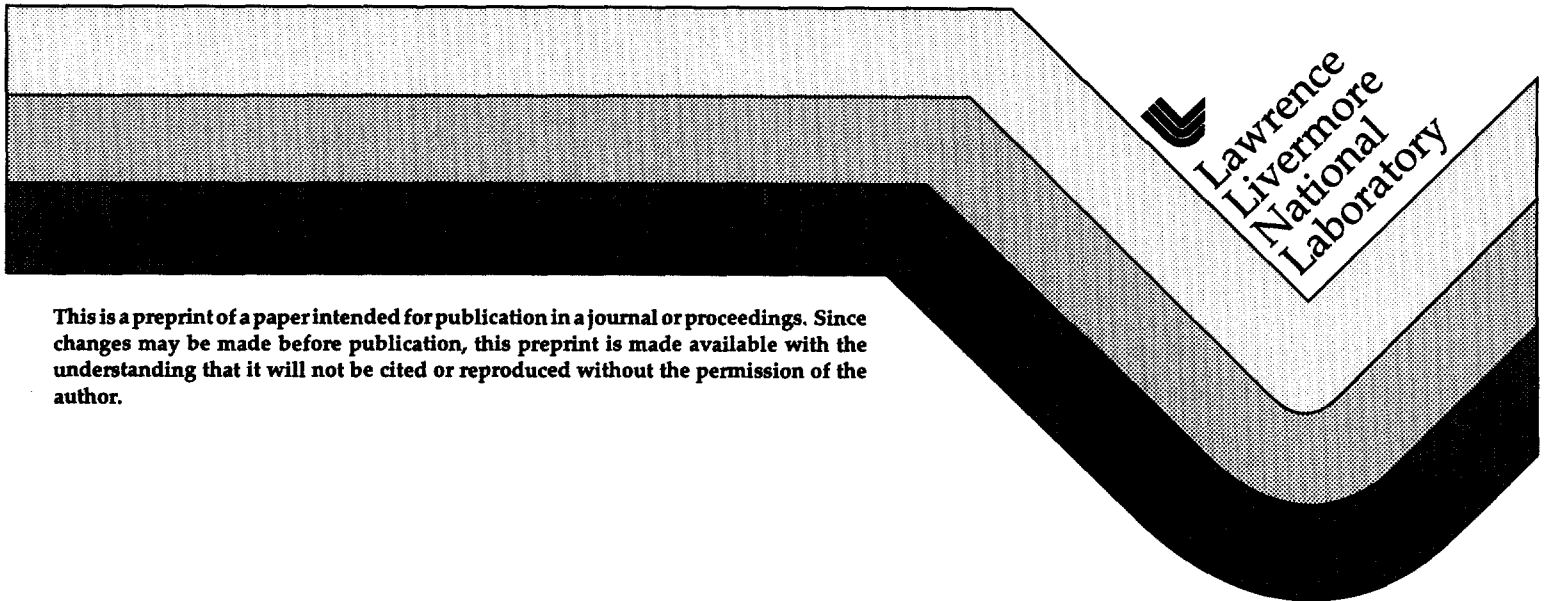
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BBU DESIGN OF LINEAR INDUCTION ACCELERATOR CELLS FOR RADIOGRAPHY APPLICATION¹

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Abstract

There is an ongoing effort to develop accelerating modules for high-current electron accelerators for advanced radiography application. Accelerating modules with low beam-cavity coupling impedances along with gap designs with acceptable field stresses comprise a set of fundamental design criteria. We examine improved cell designs which have been developed for accelerator application in several radiographic operating regimes. We evaluate interaction impedances, analyze the effects of beam structure coupling on beam dynamics (beam break-up instability and corkscrew motion). We also provide estimates of coupling through interesting new high-gradient insulators and evaluate their potential future application in induction cells.

1 INTRODUCTION

The nature of the electromagnetic interaction of a charged particle beam in an accelerator beampipe with imperfections or perturbations in the beampipe wall is of fundamental importance to the design of an induction accelerator. These interactions can be characterized by an interaction impedance, which relates moments of the beam current to the work done on the beam by the beam-induced electromagnetic fields. The impedance quantities of interest may all be derived from the characteristic wake potential W , defined by the expression

$$W(s) = \frac{1}{Q} \int_{-\infty}^{\infty} dz (\mathbf{E} + \mathbf{v} \times \mathbf{B})_{|v=s+z} \quad (1)$$

$$Z_i(\omega) = \frac{j}{v} \int_{-\infty}^{\infty} W_i(s) e^{jks} ds \quad (2)$$

Over the past fifteen years, several high current linear induction cells have been built and tested. One of the fundamental design objectives is to minimize the transverse dipole coupling impedance since the growth rate of beam breakup instability (BBU) is proportional to the transverse coupling impedance. A form factor,

$$\eta = (Z_{\perp} b^2) / (4wc) \quad (3)$$

where b is the beampipe radius and w is the gap width, is a figure of merit from the viewpoint of BBU. η is

tabulated in Figure 1 for existing cells in addition to new cell designs for advanced radiography including DARHT, and FXR-upgrade.

Cell	Beampipe radius	Gap	BBU frequency	Transverse impedance	Form factor	Characteristic
DARHT-1 Mod 2A	7.41 cm	1.91 cm	816 MHz	670 ohms/meter	1.6	Intrinsic n=2 mode
ETA-II	6.6 cm	1.5 cm	300 MHz	700 ohms/meter	1.7	BBU rings
FXR	7.3 cm	3.56 cm	800 MHz	1500 ohms/meter	1.9	Two cell types
ATA	6.725 cm	2.7 cm	800 MHz	1000 ohms/meter	1.4	Leakage current
DARHT-2 short pls	7.41 cm	2.0 cm	463 MHz	490 ohms/meter	1.1	Ferrite inset PEI6 model
FXR/U	7.3 cm	3.56 cm	350 MHz	1000 ohms/meter	1.3	Two cell types

Figure 1. Table of induction cell form factors for existing and new induction cell designs.

2 WAKEFIELD ANALYSIS

There are several features characterizing existing linear induction accelerator (LIA) cell design. Characteristic in several designs is the presence of a shielded gap. The purpose of the shielded gap design is to provide an RF filter effect for BBU modes, in addition to preventing direct line of sight between beam and insulator. Another conventional approach involves application of corner reflectors comprising either of lossy ferrite or highly conducting electric materials. These design features have also been successfully employed to both damp and direct wakefields towards lossy induction core material.

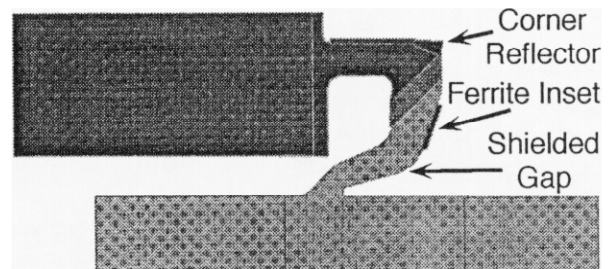


Figure 2. DARHT-2 short pulse design with ferrite inset.

Several new improvements in induction cell design hold the promise for additional suppression of beam break-up modes. Recently, we have examined the use of ferrite insets on the vacuum side of the insulator in

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designs for DARHT (Fig. 2) and AHF. The ferrite inset geometry must be designed to minimize field enhancement over the field stresses in the unperturbed cavity structure. Typical inset designs can be optimized for minimal field enhancement and recent work on DARHT-2 short pulse design has maximum field enhancements over the unperturbed case of 27%. Another key consideration is to ensure that the damping ferrites are positioned on the anode electrode to avoid possible difficulties with field induced emission.

3 DAMPING FERRITE

A key requirement for accurate impedance calculations is highly realistic material data. Data for two well-known ferrites in the LIA community are the TDK PE11b [2] and TDK PE16. We measured the magnetic dispersion characteristics of PE16 (Fig. 3). We found that in the VHF to L-band microwave spectrum, it is more lossy than TDK PE11b. In impedance calculations, the difference is manifested as a 5-10% reduction in transverse impedance. Small differences in phase due to the thickness of the ferrite sample cause the fine structure (non-physical) in the data.

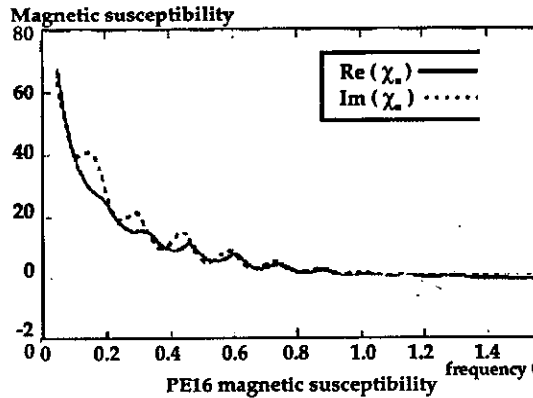


Figure 3. Magnetic dispersion for PE-16 ferrite material

4 CELL DESIGN

For two cell designs (DARHT short pulse and FXR-upgrade) the ferrite insets are employed. For the DARHT-2 design, a DARHT-1-like cell employing corner reflector yields an impedance spectrum with two BBU resonances. (~ 270 MHz and ~ 750 MHz)

The utilization of the ferrite inset on the vacuum side obtains a low-Q spectrum in Fig. 4. We found that placement of ferrite nearer to the gap yields this desirable frequency impedance dependence. We have also examined its application at FXR. For FXR, we see a similar effect in that we have a nominal impedance with conventional design featuring a BBU resonance at 800 MHz. Calculations using the damping ferrite insets on the vacuum side also obtains a low-Q impedance spectrum which we found for the DARHT-2 short pulse design. Wakefield calculations predict an upgraded FXR cell with

$\eta = 1.3$ (Fig. 5). Impedance measurements at FXR are currently in progress.

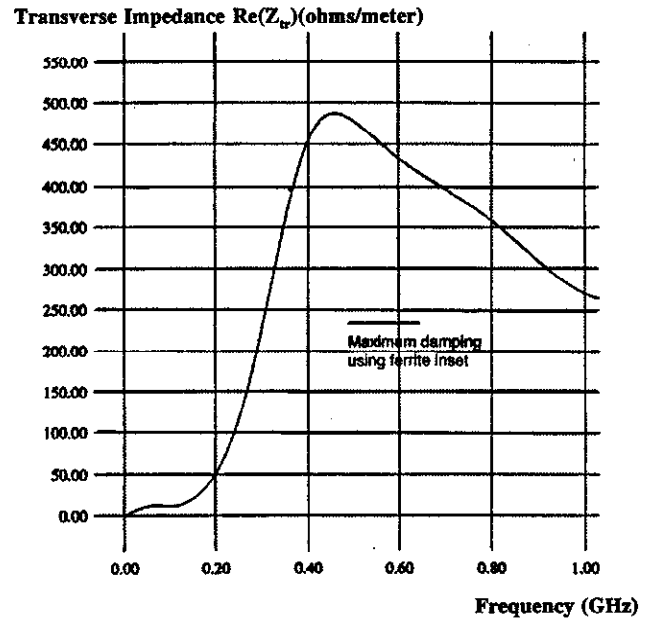


Figure 4. DARHT-2 short pulse dipole impedance spectrum with $\eta = 1.1$

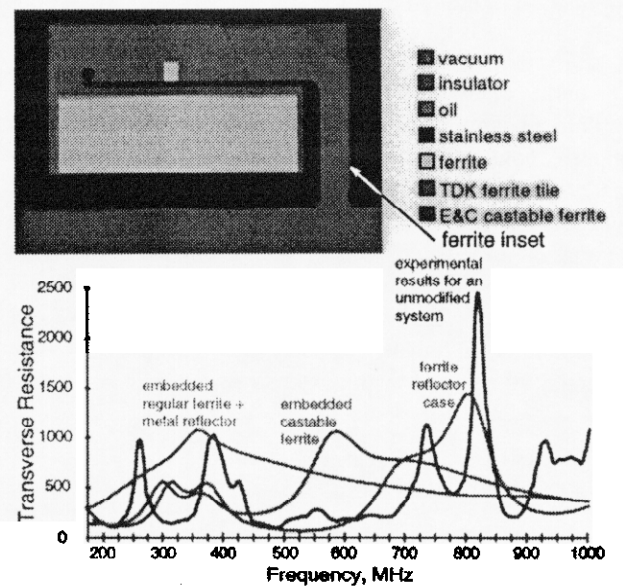


Figure 5. Computed impedance spectrum for FXR cell upgrade

5 BEAM DYNAMICS SIMULATIONS

Simulations of the beam breakup instability are required to evaluate the low-Q impedance spectrum characteristic of ferrite insets. The DARHT-2 short pulse configuration is similar to DARHT-1 except the cell and solenoid parameters are changed. The injected beam into the accelerator is at 4 MeV and 4 kA. The magnetic tune averaged at 700 G is chosen so that a beam with a 190 mm-mrad normalized edge emittance [3] is focused gently from 4.6 cm radius to about 0.6 cm radius within the first 7.5 meters, and is maintained at 0.6 cm radius through the rest of the machine.

In the simulations, the beam breakup instability is driven by misalignment of magnets. The DARHT-1 alignment specification [4] is used in the simulations. The 3- σ of random magnet tilts and random magnet offsets is 1.95 mrad and 0.45 mm, respectively. We assume that the injector and the induction cell voltages have 15 ns rise time and 70 ns flat-top with a small linear ramp. These voltage ramps introduce an $\pm 1\%$ energy variation to the beams, and hence corkscrew motion. Without any steering, the peak-to-peak (p-p) BBU amplitude and the corkscrew amplitude is 4 mm and 3 mm, respectively. Assume that beam position monitors are located between cell-blocks, and their resolution is 0.1 mm. We minimize the corkscrew amplitude by using the corkscrew tuning curve algorithm [5] and the averaged centroid displacement at alternating beam position monitors. We found that both the beam breakup instability and corkscrew motion are controllable with steering as shown in Fig. 6. The BBU only appears in the first 10 ns of the flat-top portion of the pulse, and its p-p amplitude at the end of accelerator is 1.2 mm. The corkscrew amplitude is 0.6 mm. Note that the magnetic tune used in the simulation is relatively weak. Nevertheless, both the simulated BBU amplitude and corkscrew amplitude are small enough to satisfy the final focus requirement.

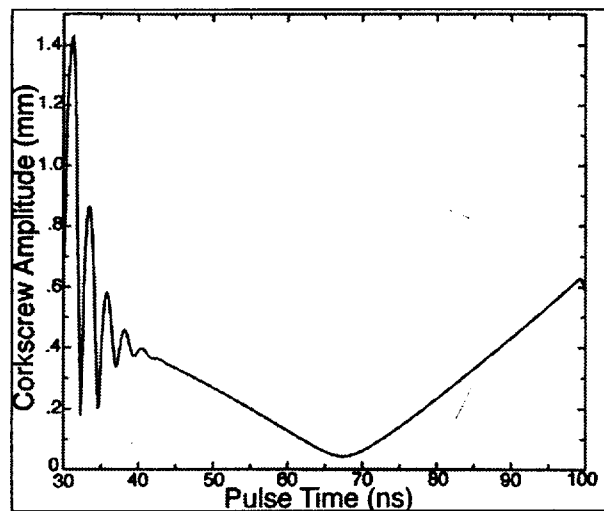


Figure 6. BBU and corkscrew motion at the end of the DARHT-2 accelerator for the short pulse option

6 HIGH GRADIENT INSULATOR STRUCTURE

It has been reported that a high gradient insulator structure, consisting of a periodic structure of alternating conductor and dielectric has voltage hold-off properties of up to 5 times conventional insulator technology [6]. In recent impedance experiments [7] it was shown that the impedance value has a strong dependence on dielectric-to-metal thickness ratio. Suitability for induction cell application also requires evaluation of the radial length and position of the insulator in the gap and its effect on impedance. In Fig. 7, by varying radial length and

position we observe that a further reduction in the interaction impedance is achievable. The effect appears to be mode dependent.

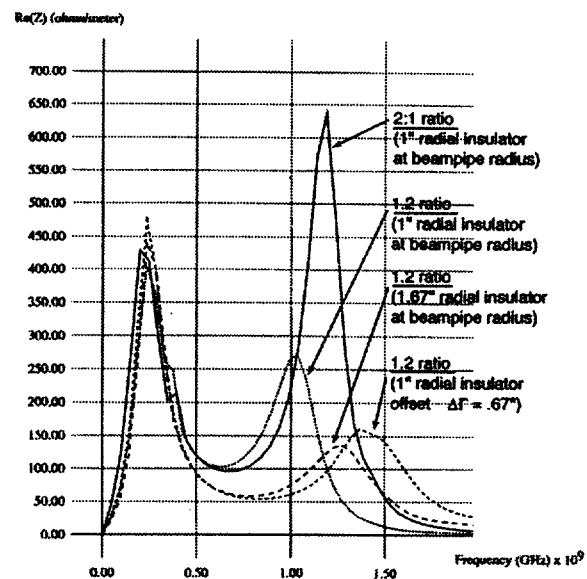


Figure 7. High gradient insulator structure in damped pillbox with ID=5.75", OD=10", and gap = 1"

7 CONCLUSION

Future induction accelerator designs may profit from new improvements involving ferrite damping materials and insulators to help achieve very low impedance structures with possibly more robust insulator performance. Experiments at FXR and AHF design and test activities are underway.

8 ACKNOWLEDGMENT

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